

<b>Notice of References Cited</b>	Application/Control No. 10/591,625		Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner SHIN-HON CHEN		Art Unit 2431	Page 1 of 1

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*	B	US-2007/0143600	06-2007	Kellil et al.	713/163
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**NON-PATENT DOCUMENTS**

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